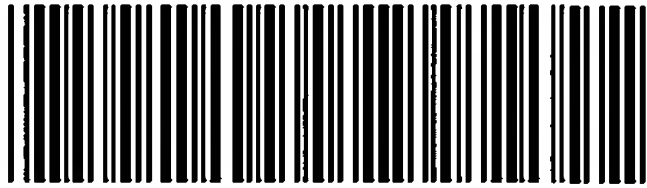


**Search Notes**

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10/617,172

Examiner

Tianjie Chen

Applicant(s)/Patent under  
Reexamination

KIM ET AL.

Art Unit

2652

**SEARCHED**

Class	Subclass	Date	Examiner
Updated		9/30/2005	TJ

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR